

AF01159

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re PATENT application of:

Applicant:

Angela Hui, et al.

Application No.:

10/045,354

For:

AN INNOVATIVE METHOD OF HARD MASK REMOVAL

Filing Date:

November 7, 2001

Examiner:

Khiem D Nguyen

Art Unit:

2823

## **REPLY TO OFFICE ACTION DATED APRIL 2, 2003**

Box Non-Fee Amendment **Assistant Commissioner for Patents** Washington, D.C. 20231

Dear Sir:

Favorable reconsideration of the above-identified application is respectfully requested in view of the following amendments and remarks.

## **AMENDMENTS**

## IN THE CLAIMS:

Please amend claims 1 and 24 as follows below:

(Amended) A method of striping a hard mask from a substrate comprising an insulating material exposed within gaps patterned through the hard mask, comprising:

coating the substrate with a sacrificial material that fills the gaps; and plasma etching to strip the sacrificial material and the hard mask in a single plasma etch process.

TECHNOLOGY CENTER 2800